

SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS

PRODUCT SPECIFICATION 規格書

CUSTOMER: DATE:

(客戶): 志盛翔 (日期): 2017-07-15

CATEGORY (品名) : ALUMINUM ELECTROLYTIC CAPACITORS

DESCRIPTION (型号) : GF 16V1000μF(φ8x16)

VERSION (版本) : 01

Customer P/N :

SUPPLIER :

SUPPLIER								
PREPARED (拟定)	CHECKED (审核)							
李婷	刘渭清							

CUSTOMER								
APPROVAL (批准)	SIGNATURE (签名)							

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

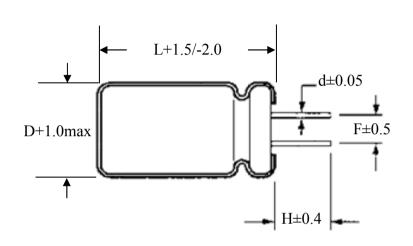
		SPECIFICAT		ALTERN.	ATION HIS ECORDS	TORY	
		GF SERIE					
Rev.	Date	Mark	Page	Contents	Purpose	Drafter	Approver

Version	01		Page	1
---------	----	--	------	---

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

Table 1 Product Dimensions and Characteristics



Unit: mm

Shape Code	D	8
2	L	16
	F	3.5
CC Type	Н	4.0
	d	0.5

N	SAMXON	WV	Cap.	Cap. tolerance	Temp.	tanδ (120Hz,	Leakage Current	Max Ripple Current at 105 °C	Impedance at 20°C	Load lifeti		ension (mm)		Sleev
0.	Part No.	(Vdc)	(μF)		range(°C)	20℃)	(μA,2min)	100kHz (mA rms)	100kHz (Ωmax)	me (Hrs)	$D \times L$	F	фd	e
1	EGF108M1CF16CC**P1	16	1000	-20%~+20%	-40~105	0.16	160	840	0.087	3000	8X16	3.5	0.5	PET

Version	01	Page	2

Attachment: Application Guidelines

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

12~15

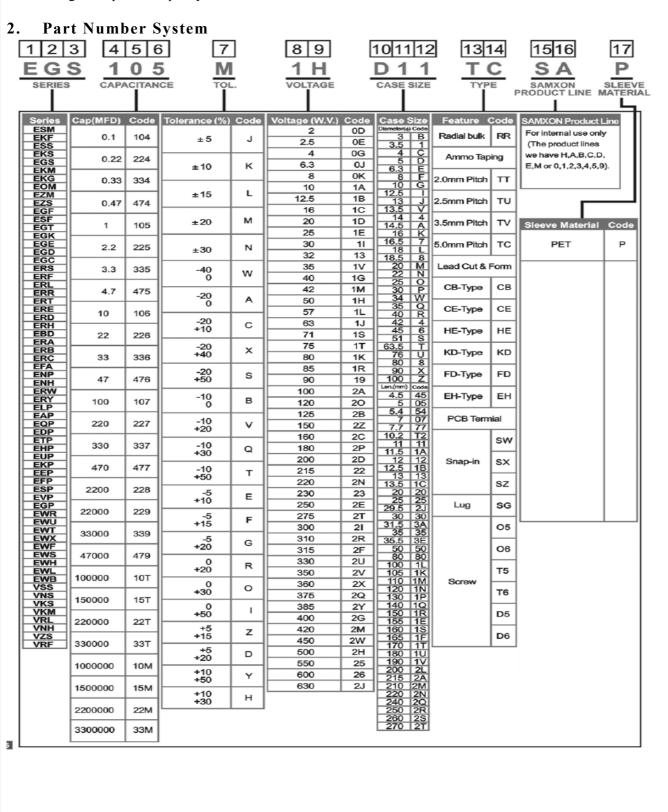
CONTENTS Sheet 4 1. Application 2. Part Number System 4 3. Construction 5 4. Characteristics 5~10 4.1 Rated voltage & Surge voltage 4.2 Capacitance (Tolerance) 4.3 Leakage current 4.4 $\tan \delta$ 4.5 Terminal strength 4.6 Temperature characteristic 4.7 Load life test 4.8 Shelf life test 4.9 Surge test 4.10 Vibration 4.11 Solderability test 4.12 Resistance to solder heat 4.13 Change of temperature 4.14 Damp heat test 4.15 Vent test 4.16 Maximum permissible (ripple current) 5. List of "Environment-related Substances to be Controlled ('Controlled 11 Substances')"

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.



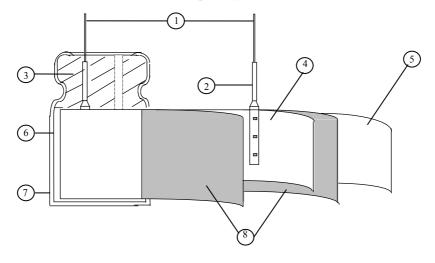
Version	01		Page	4	ı
---------	----	--	------	---	---

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature :15°C to 35°C
Relative humidity : 45% to 85%
Air Pressure : 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature : $20^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Relative humidity : 60% to 70%Air Pressure : 86kPa to 106kPa

Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

Version	01		Page	5
---------	----	--	------	---

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

	ITEM				PERFO	RMANC	CE				
	Rated voltage										
	(WV)	WV (V.DC)	6.3	10	16	25	35	50	63	100	
4.1		SV (V.DC)	8	13	20	32	44	63	79	125	
	Surge voltage (SV)										
4.2	Nominal capacitance (Tolerance)	Condition> Measuring F Measuring Vo Measuring T Criteria> Shall be with	requency oltage emperat	: N ure : 20)±2℃	than 0.5V					
4.3	Leakage current	<condition></condition> Connecting the capacitor with a protective resistor $(1k\Omega \pm 10\Omega)$ in series for 2 minutes, and then, measure Leakage Current. <criteria></criteria> Refer to Table 1									
4.4	tan δ	See 4.2, Norr	<condition> See 4.2, Norm Capacitance, for measuring frequency, voltage and temperature. <criteria> Refer to Table 1</criteria></condition>								
		Condition> Tensile Street Street the conditions Street	ength of apacitor rength of pacitor,	f, applied f Termina applied f	force to als. Force to b then ber	ent the te	rminal (1	l∼4 mm f original _l	from the position	rubber) f	
4.5	Terminal	Diamet	er of lea	d wire		ile force (kgf)	IN	Bending (kg			
-	strength		nm and			5 (0.51)		2.5 (0.25)		
		Over 0.	5mm to	0.8mm	1	0 (1.0)		5 (0	.51)		
		<criteri No notic</criteri 		nanges sh	all be for	ınd, no b	reakage	or loosen	ess at the	e termina	

Version	01		Page	6
---------	----	--	------	---

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

		<condition></condition>								
		STEP	Testi	ng Tempe	rature(°C)			Time		
		1	20±		2	Time	Time to reach thermal equilibrium		ım	
		2		-40(-25)	<u>+3</u>	Time	to reach	thermal	equilibrii	ım
		3 20				_	to reach			
		4		105±		-	to reach		•	
		5		$\frac{103\pm}{20\pm2}$		_	to reach			
		Criteria>		20 1 2	<u></u>	Tille	to reach	uieiiiai (equinoin	1111
			:41.	: 41 1:	:4 - C T4	4 4Th - 1	1			1 11 4
		a. tan δ shall be more than 8 time				4.411161	eakage cu	ment me	easured s	пан пос
	Temperature			-		it of Ita	n 4 4Tha	lankana	aurrant	ahall na
	characteristi	b. In step 5, tan more than the sp			iiii uie iiii	iit or iter	11 4.41116	leakage	Current	snan no
	cs	c. At-40°C (-25			(z) ratio	hall not	aveaad th	ر میراییم	of the fol	lowing
		table.	C), II	прецапсе	(Z) Tatio s	man not	exceed iii	ie value (or the for	lowing
		Working Voltage	(1/)	6.3	10	16	25	35	50	63
					+					-
		Z-25°C/Z+20°C		4	3	2	2	2	2	2
		Z-40°C/Z+20°C	C	8	6	4	3	3	3	3
		Working Voltage	(V)	100	Ī					
		Z-25°C/Z+20°C		2	1					
		Z-40°C/Z+20°C		3						
					J		.1 100/		7.05/7.	20°C
		For capacitance value $> 1000 \mu$ F, Add 0.5 per another 1000μ F for Z-25/Z+20°C, Add 1.0 per another 1000μ F for Z-40°C/Z+20°C								
		roi capacitance	varue	> 1000 µ		-				
		Capacitance, tan			Add 1.0	per ano	ther 1000	μF for .		
		-			Add 1.0	per ano	ther 1000	μF for .		
		Capacitance, tan	δ , and	d impedar	Add 1.0	per ano e measur	ther 1000 red at 120)μF for .)Hz.	Z-40°C/Z	Z+20°C.
		Capacitance, tan 6 <condition> According to IEC</condition>	δ , and	d impedar 34-4No.4.	Add 1.0 nce shall b	per ano e measur	ther 1000 red at 120 apacitor is) μ F for a OHz. s stored a	Z-40°C/Z	Z+20°C.
		Capacitance, tan 6 <condition> According to IEC 105°C ±2 with I</condition>	δ , and C6038 DC bi	d impedar 34-4No.4. as voltage	Add 1.0 nce shall b	per ano e measur s, The ca ated ripp	ther 1000 red at 120 apacitor is	μ F for . OHz. s stored at for Tab	Z-40°C/Z at a temp ble 1. (Ti	Z+20°C. erature content to the sum of the
		Capacitance, tan 6 <condition> According to IEC</condition>	δ, and C6038 DC bi	d impedar 34-4No.4. as voltage voltage sh	Add 1.0 nce shall b	b per ano e measures, The ca ated ripp	ther 1000 red at 120 apacitor is le curren e rated w) \(\mathbb{F} \) for \(\text{P} \) S stored a t for Tabyorking \(\text{Vorking} \)	Z-40°C/Z	Z+20°C. erature of the sum of then the the sum of the
	Load	Capacitance, tan 6 <condition> According to IEC 105°C ±2 with I DC and ripple p</condition>	δ, and C6038 DC bipeak voe teste	d impedar 34-4No.4. as voltage voltage shed after 16	Add 1.0 nce shall b	b per ano e measures, The ca ated ripp	ther 1000 red at 120 apacitor is le curren e rated w) \(\mathbb{F} \) for \(\text{P} \) S stored a t for Tabyorking \(\text{Vorking} \)	Z-40°C/Z	Z+20°C. erature of the sum of then the the sum of the
4.7	Load life	Capacitance, tan a condition According to IEC 105°C ±2 with IDC and ripple product should be result should med Criteria	δ, and C6038 DC bit peak we testo et the	d impedar 34-4No.4. as voltage voltage shed after 16 following	Add 1.0 nce shall b	b per ano e measures, The ca ated ripp acced the	ther 1000 red at 120 apacitor is le current e rated within at at) \(\mathbb{F} \) for \(\text{P} \) S stored \(\text{a} \) t for \(\text{Tab} \)	Z-40°C/Z	Z+20°C. erature of the sum of then the the sum of the
		Capacitance, tan a Condition According to IEC 105°C ±2 with I DC and ripple product should b result should median.	δ, and C6038 DC bit peak we testo et the	d impedar 34-4No.4. as voltage voltage shed after 16 following	Add 1.0 nce shall b	b per ano e measures, The ca ated ripp acced the	ther 1000 red at 120 apacitor is le current e rated within at at) \(\mathbb{F} \) for \(\text{P} \) S stored \(\text{a} \) t for \(\text{Tab} \)	Z-40°C/Z	Z+20°C. erature of the sum of the the the sum of the the sum of the the sum of the sum
	life	Capacitance, tan a condition According to IEC 105°C ±2 with IDC and ripple product should be result should med Criteria	δ, and C6038 DC bi peak vote teste et the ic sha	d impedar 34-4No.4. as voltage voltage shed after 16 following	Add 1.0 nce shall b	b per ano e measured s, The ca ated ripp acced the covering	ther 1000 ped at 120 apacitor is le currente rated when at at attention at the currents.	D μ F for DHz. s stored at for Tabyorking wospher	Z-40°C/Z	Z+20°C. erature of the sum of the the the sum of the the sum of the the the sum of the the the sum of the sum
4.7	life	Capacitance, tan a condition According to IEC 105°C ±2 with I DC and ripple product should b result should me contents. The characteristic	δ, and C6038 DC bit peak to be tested the cet the cet sharp current control of the cet the ce	d impedar 34-4No.4. as voltage shed after 16 following	Add 1.0 nce shall be 13 method e plus the reall not ex 6 hours receptable:	by per anough the measure of the cated ripp acceed the covering grequire 4.3 shall	ther 1000 ped at 120 apacitor is le currente rated whime at at the ments.	D μ F for DHz. s stored at for Tabyorking with mospher	Z-40°C/Z	Z+20°C. erature of the sum of the the the sum of the the sum of the the the sum of the the the sum of the sum
4.7	life	Capacitance, tan a condition According to IEC 105°C ±2 with I DC and ripple product should b result should med Criteria The characteristic Leakage of	δ, and C6038 DC bit peak to be tested the cet the cet sharp current control of the cet the ce	d impedar 34-4No.4. as voltage shed after 16 following	Add 1.0 nce shall be a shall not explus the real not explusive table: e following Value in Within ±	b per ano e measures, The ca ated ripp acced the covering g require 4.3 shall 25% of	apacitor is le current e rated white at at the ments.	D µ F for DHz. s stored at for Tabyorking with mospher field field filler.	Z-40°C/Z	Z+20°C. erature of the sum of the the the sum of the the sum of the the the sum of the the the sum of the sum
4.7	life	Capacitance, tan δ Condition> According to IEC 105°C ±2 with I DC and ripple p product should b result should med Criteria> The characteristic Leakage c Capacitan tan δ	δ, and C6038 DC bit peak we teste the cic share current ce Ch	d impedar 34-4No.4. as voltage shed after 16 following	Add 1.0 nee shall be 13 method e plus the reall not ex 6 hours reag table: e followin Value in Within ± Not more	ls, The cated ripper acceed the covering grequire 4.3 shall 25% of than 15	apacitor is le curren e rated when the satisficial value of the control of the curren at the current at	D µ F for DHz. S stored at for Tabyorking windsphered ied alue.	z-40°C/z at a temp ble 1. (The voltage) ric condite	Z+20°C. erature of the sum of the the the sum of the the sum of the the the sum of the the the sum of the sum
4.7	life	Capacitance, tan a condition According to IEC 105°C ±2 with I DC and ripple product should be result should med Criteria The characteristic Leakage of Capacitan	δ, and C6038 DC bit peak we teste the cic share current ce Ch	d impedar 34-4No.4. as voltage shed after 16 following	Add 1.0 nce shall be a shall not explus the real not explusive table: e following Value in Within ±	ls, The cated ripper acceed the covering grequire 4.3 shall 25% of than 15	apacitor is le curren e rated when the satisficial value of the control of the curren at the current at	D µ F for DHz. S stored at for Tabyorking windsphered ied alue.	z-40°C/z at a temp ble 1. (The voltage) ric condite	Z+20°C. erature of the sum of then the the sum of the
4.7	life	Capacitance, tan 6 <condition> According to IEC 105°C ±2 with I DC and ripple p product should b result should med <criteria> The characteristi Leakage c Capacitan tan 8 Appearance</criteria></condition>	δ, and C6038 DC bit peak we teste the cic share current ce Ch	d impedar 34-4No.4. as voltage shed after 16 following	Add 1.0 nee shall be 13 method e plus the reall not ex 6 hours reag table: e followin Value in Within ± Not more	ls, The cated ripper acceed the covering grequire 4.3 shall 25% of than 15	apacitor is le curren e rated when the satisficial value of the control of the curren at the current at	D µ F for DHz. S stored at for Tabyorking windsphered ied alue.	z-40°C/z at a temp ble 1. (The voltage) ric condite	Z+20°C. erature of the sum of the the the sum of the the sum of the the the sum of the the the sum of the sum
4.7	life	Capacitance, tan a condition According to IEC 105°C ±2 with I DC and ripple product should be result should med Criteria The characteristic Leakage of Capacitan tan a Appearance Condition	δ, and C6038 DC bit peak where testing the centre ic sharper control in the centre ce	d impedar 34-4No.4. as voltage shed after 16 following	Add 1.0 nce shall be 13 method e plus the reall not ex 6 hours reall table: e following Value in Within 1/2 Not more	ls, The cated ripper acceed the covering grequire 4.3 shall 25% of than 15 all be no	apacitor is le curren e rated whime at at ments. be satisficinitial value of the leakage of the satisficial value of the leakage of the satisficial value of the leakage of the satisficial value of the satisficial value of the leakage of the satisficial value of the satis	D µ F for DHz. S stored at for Tabyorking wind mospher ied halue. e specified of electron	z-40°C/z at a temp ble 1. (Ti voltage) ric condit ed value. blyte.	erature of the sum of Then the thions. The
4.7	life	Capacitance, tan a condition According to IEC 105°C ±2 with IDC and ripple product should be result should med Criteria The characteristic Leakage of Capacitan tan δ Appearance Condition The capacitors are	δ, and C6038 DC bit peak we teste the certification of the certificatio	d impedar 34-4No.4. as voltage shed after 16 following Ill meet the thange	Add 1.0 nce shall be 13 method e plus the reall not ex 6 hours recog table: e following Value in Within ± Not more there shall the real work with the real to the real with the real to t	ls, The cated ripper acceed the covering grequired 4.3 shall to than 15 all be no	apacitor is le currente rated when the satisficinitial various of the leakage of the data at a terms.	D µ F for DHz. S stored at for Tabyorking with mospher mospher mospher mospher mospher mospher metallic.	z-40°C/z at a temp ble 1. (Ti voltage) ric condit ed value. blyte.	erature of the sum of Then the thions. The
4.7	life	Capacitance, tan 6 Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should med Criteria> The characteristic Leakage of Capacitan tan 8 Appearant Condition> The capacitors are 3000+48/0 hours	δ, and C6038 DC bit peak where the cet the cet the cet cet cet cet cet cet cet cet cet ce	d impedar 34-4No.4. as voltage shed after 16 following the	Add 1.0 nce shall be 13 method e plus the real not ex 6 hours read table: e followin Value in Within ± Not more There shall not ex 6 hours read table: the no voltage is period to the content of t	ls, The ca ated ripp acced the covering g require 4.3 shall 25% of than 15 all be no	apacitor is le currente rated witime at at ments. be satisficinitial various of the leakage of	D µ F for DHz. S stored at for Tabyorking wind mospher ied alue. E specific of electromagnetic properature of the premium o	z-40°C/z at a temp ble 1. (Ti voltage) ric condit ed value. blyte.	± 2°C form the test
4.7	life	Capacitance, tan 6 Condition> According to IEC 105°C ±2 with I DC and ripple p product should b result should me Criteria> The characteristic Leakage c Capacitan tan δ Appearance Condition> The capacitors are 3000+48/0 hours chamber and be	δ, and C6038 DC bit peak where the tested the current ce Change ethen s. Follows.	d impedar 34-4No.4. as voltage shed after 16 following Ill meet the tange stored will owing this red to stale	Add 1.0 nce shall be 13 method e plus the real not ex 6 hours read table: e followin Value in Within ± Not more There shall the real table is period the bilized at the shall be the real table.	b per ano e measured system of the covering of	apacitor is le current e rated writine at at at at at a series le current e rated writine at at at a series le current e rated writine at at at at a series le current e rated writine at at at at a series le current e rated writine at	p µ F for DHz. s stored at for Tabyorking with mospher mospher mospher mospher mospher metallue. e specific of electromagnetic materials at the removes for 4~8	z-40°C/z at a temp ble 1. (Ti voltage) ric condit ed value. blyte. re of 105 oved from hours. I	±2°C form the test
4.7	life test	Capacitance, tan δ Condition> According to IEC 105°C ±2 with I DC and ripple p product should b result should med Criteria> The characteristic Leakage of Capacitant tan δ Appearant Condition> The capacitors are 3000+48/0 hours chamber and be shall be connect	δ, and C6038 DC bit peak we teste the cic share current ce Character then allow ted to	d impedar 34-4No.4. as voltage shed after 16 following Ill meet the thange stored with the sto	Add 1.0 nce shall be 13 method e plus the reall not ex 6 hours reall to the following table: e following Value in Within ± Not more than the work with the real to the period the bilized at a limiting real to the property of the period the pe	by per anough and per anough	ther 1000 ped at 120 ped at 120 ped at 120 ped at 120 ped at at at the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall ped at a ten	p µ F for DHz. s stored at for Tabyorking with mospher mospher mospher mospher mospher metallic before effective for 4~8) with I	z-40°C/z at a temp ble 1. (Ti voltage) ric condit ed value. blyte. re of 105 oved from hours. 1 D.C. rate	±2°C form the test
	life test Shelf	Capacitance, tan 6 Condition> According to IEC 105°C ±2 with I DC and ripple p product should b result should me Criteria> The characteristic Leakage c Capacitan tan δ Appearance Condition> The capacitors are 3000+48/0 hours chamber and be	δ, and C6038 DC bit peak we teste the cic share current ce Character then allow ted to	d impedar 34-4No.4. as voltage shed after 16 following Ill meet the thange stored with the sto	Add 1.0 nce shall be 13 method e plus the reall not ex 6 hours reall to the following table: e following Value in Within ± Not more than the work with the real to the period the bilized at a limiting real to the property of the period the pe	by per anough and per anough	ther 1000 ped at 120 ped at 120 ped at 120 ped at 120 ped at at at the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall ped at a ten	p µ F for DHz. s stored at for Tabyorking with mospher mospher mospher mospher mospher metallic before effective for 4~8) with I	z-40°C/z at a temp ble 1. (Ti voltage) ric condit ed value. blyte. re of 105 oved from hours. 1 D.C. rate	±2°C form the test
	life test Shelf life	Capacitance, tan δ Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should med Criteria> The characteristic Leakage of Capacitan tan δ Appearance Condition> The capacitors are 3000+48/0 hours chamber and be shall be connect applied for 30min	δ, and C6038 DC bit peak we teste the cic share current ce Character then allow ted to	d impedar 34-4No.4. as voltage shed after 16 following Ill meet the thange stored with the sto	Add 1.0 nce shall be 13 method e plus the reall not ex 6 hours reall to the following table: e following Value in Within ± Not more than the work with the real to the period the bilized at a limiting real to the property of the period the pe	by per anough and per anough	ther 1000 ped at 120 ped at 120 ped at 120 ped at 120 ped at at at the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall ped at a ten	p µ F for DHz. s stored at for Tabyorking with mospher mospher mospher mospher mospher metallic before effective for 4~8) with I	z-40°C/z at a temp ble 1. (Ti voltage) ric condit ed value. blyte. re of 105 oved from hours. 1 D.C. rate	±2°C form the test
	life test Shelf life	Capacitance, tan δ Condition> According to IEC 105°C ±2 with I DC and ripple p product should be result should med Criteria> The characteristic Leakage of Capacitan tan δ Appearance Condition> The capacitors are 3000+48/0 hours chamber and be shall be connect applied for 30min	δ, and C6038 DC bit peak we teste the cic share current ce Character then allow ted to	d impedar 34-4No.4. as voltage shed after 16 following Ill meet the thange stored with the sto	Add 1.0 nce shall be 13 method e plus the reall not ex 6 hours reall to the following table: e following Value in Within ± Not more than the work with the real to the period the bilized at a limiting real to the property of the period the pe	by per anough and per anough	ther 1000 ped at 120 ped at 120 ped at 120 ped at 120 ped at at at the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall perature to the second ped at a tent to shall ped at a ten	p µ F for DHz. s stored at for Tabyorking with mospher mospher mospher mospher mospher metallic before effective for 4~8) with I	z-40°C/z at a temp ble 1. (Ti voltage) ric condit ed value. blyte. re of 105 oved from hours. 1 D.C. rate	±2°C form the test

Version	01		Page	7
---------	----	--	------	---

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

		<criteria></criteria>	
		The characteristic shall meet the following requirements.	
		Leakage current Value in 4.3 shall be satisfied	
4.0	Shelf	Capacitance Change Within $\pm 25\%$ of initial value.	
4.8	life	tan δ Not more than 150% of the specified	value.
	test	Appearance There shall be no leakage of electrol	yte.
		Remark: If the capacitors are stored more than 1 year, the leakage cur	rrent may
		increase. Please apply voltage through about 1 k \(\Omega\) resistor, if necessa	ry.
4.9	Surge test	Condition Applied a surge voltage to the capacitor connected with a (100 ±50)/0 The capacitor shall be submitted to 1000 cycles, each consisting of che followed discharge of 5 min 30s. The test temperature shall be 15~35°C. Criteria Criteria Leakage current Not more than the specified value. Capacitance Change Within ±15% of initial value. Leakage current Not more than the specified value. Capacitance Change Within ±15% of initial value. Appearance There shall be no leakage of electroly. Attention: This test simulates over voltage at abnormal situation only. It is not apover voltage as often applied.	rarge of 30 ±5s,
4.10	Vibration test	Condition> The following conditions shall be applied for 2 hours in each 3 mutu perpendicular directions. Vibration frequency range : 10Hz ~ 55Hz Peak to peak amplitude : 1.5mm Sweep rate : 10Hz ~ 55Hz ~ 10Hz in about Mounting method: The capacitor with diameter greater than 12.5mm or longer than 25m in place with a bracket. Within 30° 4mm or less Within 30° Within 30° After the test, the following items shall be tested: Inner construction No intermittent contacts, open or short cine No damage of tab terminals or electrode No mechanical damage in terminal. No of electrolyte or swelling of the case. The markings shall be legible.	I minute m must be fixed reuiting.

Version	01		Page	8
---------	----	--	------	---

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

		<condition></condition>				
		The capacitor shall be tes	_	conditions:		
		Soldering temperature : 245±3°C				
	Coldorability	Dipping depth	: 2mm			
4.11	Solderability test	Dipping speed	: 25±2.5mr	n/s		
	test	Dipping time <criteria></criteria>	: 3±0.5s			
		Coating quality	A minimu immersed	m of 95% of the surface bein	ng	
		<condition></condition>				
		Terminals of the capacito	r shall be immersed in	to solder bath at $260\pm5^{\circ}\mathrm{C}$ f	for10	
		1seconds or $400 \pm 10^{\circ}$ C for	or3 $^{+1}_{-0}$ seconds to 1.5~2.	Omm from the body of capac	citor .	
				temperature and normal hur		
	Resistance to	for 1~2 hours before mea		•	,	
4.12 solder heat test	solder heat	<criteria></criteria>				
	test	Leakage current	Not more than	the specified value.		
	Capacitance Change	Within ±10%	of initial value.			
		tan δ	Not more than	the specified value.		
		Appearance	There shall be	no leakage of electrolyte.		
		<condition></condition>				
			rding to IEC60384-4No	o.4.7methods, capacitor shall	l be	
		placed in an oven, the con				
		Te	emperature	Time		
		(1)+20°C		≤3 Minutes		
	Change of	(2)Rated low temper	ature (-40°C) (-25°C)	30 ± 2 Minutes		
4.13	temperature	(3)Rated high temper	rature (+105°C)	30 ± 2 Minutes		
	test	(1) to $(3)=1$ cycle, to	tal 5 cycle			
		<criteria></criteria>				
		The characteristic shall m				
			Not more than the			
		tan δ	Not more than the	•		
		Appearance	There shall be no l	eakage of electrolyte.		
		<condition></condition>				
		Humidity Test:	ANT. 4.10 4 . 1		00 0	
		_	-	ncitor shall be exposed for 50°		
		-		$2^{\circ}\mathbb{C}$, the characteristic change	e sna	
		meet the following requir <criteria></criteria>	ement.			
	Damp heat	Leakage current	Not more than the spe	ecified value		
4.14	test	Capacitance Change	Within $\pm 20\%$ of ini			
		tan 8		of the specified value.		
		Appearance	There shall be no leal	-		

Version	01		Page	9
---------	----	--	------	---

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

4.15	Vent test	<criteria> The vent shall operate with no pieces of the capacitor and/or c</criteria>	th its polarible is applied rent (A)	ity reversed ed.	to a DC po	ower source	. Then a
		Condition> The maximum permissible rip at 120Hz and can be applied Table-1 The combined value of D.C rated voltage and shall not reserved. Frequency Multipliers: Coefficient Freq. (Hz) Cap. (μ F)	at maximu	m operating I the peak A	g temperatu	re	ceed the
	Maximum permissible	~180	0.40	0.75	0.90	1.00	
4.16	(ripple	220~560	0.40	0.75	0.90	1.00	
	current)	680~1800	0.60	0.87	0.95	1.00	
	ĺ	2200~3900	0.75	0.90	0.95	1.00	
		4700	0.85	0.95	0.98	1.00	

Version	01		Page	10
---------	----	--	------	----

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances					
	Cadmium and cadmium compounds					
Heavy metals	Lead and lead compounds					
Ticavy metais	Mercury and mercury compounds					
	Hexavalent chromium compounds					
	Polychlorinated biphenyls (PCB)					
Chloinated	Polychlorinated naphthalenes (PCN)					
organic	Polychlorinated terphenyls (PCT)					
compounds	Short-chain chlorinated paraffins(SCCP)					
	Other chlorinated organic compounds					
D : 1	Polybrominated biphenyls (PBB)					
Brominated	Polybrominated diphenylethers(PBDE) (including					
organic	decabromodiphenyl ether[DecaBDE])					
compounds	Other brominated organic compounds					
Tributyltin comp	ounds(TBT)					
Triphenyltin com	apounds(TPT)					
Asbestos						
Specific azo com	pounds					
Formaldehyde						
Beryllium oxide						
Beryllium copp	er					
Specific phthalat	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)					
Hydrofluorocarb	on (HFC), Perfluorocarbon (PFC)					
Perfluorooctane :	sulfonates (PFOS)					
Specific Benzotr	iazole					

Version	01		Page	11
---------	----	--	------	----

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

Attachment: Application Guidelines

1.Circuit Design

1.1 Operating Temperature and Frequency

Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.

- 1) Effects of operating temperature on electrical parameters
 - a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
 - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
 - a) At higher frequencies capacitance and impedance decrease while tanδ increases.
 - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).

1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

(1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

1.4 Using Two or More Capacitors in Series or Parallel

(1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

1.5 Capacitor Mounting Considerations

(1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2) Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3) Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

Version 01 Page 12

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

(6) Wiring Near the Pressure Relief Vent

Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite.

(7) Circuit Board patterns Under the Capacitor

Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short.

(8) Screw Terminal Capacitor Mounting

Do not orient the capacitor with the screw terminal side of the capacitor facing downwards.

Tighten the terminal and mounting bracket screws within the torque range specified in the specification.

1.6 Electrical Isolation of the Capacitor

Completely isolate the capacitor as follows.

- (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths
- (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.
- 1.7 The Product endurance should take the sample as the standard.
- 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.

1.9 Capacitor Sleeve

The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor.

The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.

CAUTION!

Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use.

- (1) Provide protection circuits and protection devices to allow safe failure modes.
- (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.

2. Capacitor Handling Techniques

- 2.1 Considerations Before Using
- (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment.
- (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about 1kΩ.
- (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately $1k\Omega$.
- (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors.
- (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.

2.2 Capacitor Insertion

- (1) Verify the correct capacitance and rated voltage of the capacitor.
- (2) Verify the correct polarity of the capacitor before inserting.
- (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals.
- (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor.

For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.

2.3 Manual Soldering

- (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less.
- (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal.
- (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads.
- (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.

2.4 Flow Soldering

- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.

2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

Version 01 Page 13	
--------------------	--

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

- 2.6 Capacitor Handling after Solder
- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.

2.7 Circuit Board Cleaning

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

Alkali solvents : could attack and dissolve the aluminum case.

Petroleum based solvents: deterioration of the rubber seal could result.

Xylene : deterioration of the rubber seal could result.

Acetone : removal of the ink markings on the vinyl sleeve could result.

- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

3. Precautions for using capacitors

3.1 Environmental Conditions

Capacitors should not be stored or used in the following environments.

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed $100\,^{\circ}\mathrm{C}$ temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000Ω , current limiting resistor for a time period of 30 minutes . If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

Version 01 Page 14

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SAMXON

The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

Version	01	Page	15
, , , , , , , , , , , , , , , , , , , ,	~ -		